## Notice of References Cited Application/Control No. 10/707,762 Examiner Tae H. Yoon Applicant(s)/Patent Under Reexamination YIN ET AL. Art Unit 1714 Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,165,390	08-1979	Saladini et al.	426/540
*	В	US-5,596,025	01-1997	Oxman et al.	523/109
*	С	US-6,162,931	12-2000	Gee et al.	549/223
*	D	US-2004/0054195 A1	03-2004	Gao et al.	549/223
*	Ε	US-2006/0106458 A1	05-2006	Jason et al.	623/006.11
	F	US-			,
	G	US-			
	Н	US-			
	_	US-			
	7	US-			
	К	US-			
	اد	US-			
	Δ	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					,
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.